

IN THE U.S. PATENT AND TRADEMARK OFFICE  
January 18, 2006

Applicant(s) : Eiji FUJISAWA et al  
For : OPTICAL SWITCH DEVICE

Serial No. : Unknown Group: Unknown  
Confirmation No.: Unknown  
Filed : Unknown Examiner: Unknown  
International Application No. : PCT/JP2004/011087  
International Filing Date : August 3, 2004  
Atty. Docket No.: 5725.P0019US

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

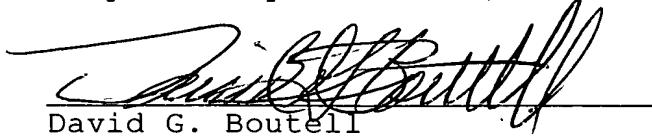
Sir:

In compliance with the provisions of Rules 1.97(b)(1) and 1.98, enclosed herewith is a copy of the International Search Report for the PCT application corresponding to the present application, Form PTO-1449 and the references cited thereon.

The relevance of the enclosed references is explained on the enclosed International Search Report. Further comment at this point in time should not be necessary.

Further consideration is respectfully solicited.

Respectfully submitted,



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David G. Boutell

DGB/DJW/jas

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Encl: Form PTO-1449 and references cited thereon  
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| INFORMATION<br>DISCLOSURE<br>CITATION |  | Applicant: Eiji FUJISAWA et al<br>Ser.No.: Unknown<br>Conf. No.: Unknown<br>Group: Unknown | Filed: Unknown<br>Atty. Docket No.: 5725.P0019US |
| Date: January 18, 2006                |  |  |  |

## U.S. PATENT DOCUMENTS

| Examiner Initials* | Cite No. | Document Number - Kind Code | Publication Date MM-DD-YYYY | Name of Patentee or Applicant |
|--------------------|----------|-----------------------------|-----------------------------|-------------------------------|
|                    | AA       |                             |                             |                               |
|                    | AB       |                             |                             |                               |
|                    | AC       |                             |                             |                               |
|                    | AD       |                             |                             |                               |
|                    | AE       |                             |                             |                               |
|                    | AF       |                             |                             |                               |
|                    | AG       |                             |                             |                               |
|                    | AH       |                             |                             |                               |
|                    | AI       |                             |                             |                               |
|                    | AJ       |                             |                             |                               |
|                    | AK       |                             |                             |                               |

## FOREIGN PATENT DOCUMENTS

| Examiner Initials* | Cite No. | Country Code - Document Number - Kind Code | Publication Date MM-DD-YYYY | Name of Patentee or Applicant | Trans.   |
|--------------------|----------|--|-----------------------------|-------------------------------|----------|
|                    | AL       | JP 58-007601                               | 01-17-1983                  | Fujitsu Ltd.                  | Abstract |
|                    | AM       | JP 2593477                                 | 10-18-1994                  | Nihon Kaiheiki Ind. Co. Ltd.  |          |
|                    | AN       | JP 2001-272612                             | 10-05-2001                  | Sun Tec KK                    | Abstract |
|                    | AO       | JP 2002-250874                             | 09-06-2002                  | Agilent Technol Inc.          | Abstract |
|                    | AP       | JP 2004-094188                             | 03-25-2004                  | Omron Corp.                   | Abstract |

## NON PATENT LITERATURE DOCUMENTS

|                    |          |   |
|--------------------|----------|---|
| Examiner Initials* | Cite No. | (Include Author, Title, Date, Pages, Etc.)                        |
|                    | AQ       | International Search Report dated September 28, 2004<br>(2 pages) |
| EXAMINER SIGNATURE |          | DATE CONSIDERED   |

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.